

Sergei Odintsov

This year European Test Symposium and linked to the conference Test Spring School took place in the student's city Cluj-Napoca in Romania. We can call it student's city, because there are seven universities and nearly one fourth of the city habitants are students. Together spring school, conference and workshop covered wide range of test and reliability related topics during nine days without a break. Test Spring School also covered some not very obvious but interesting topics like testing and reliability of biochips and emerging electron spin variable memories. For student like me, this was a great opportunity to learn about state of the art in the field of electronics test and reliability and discuss new research problems with leading specialists. In addition, vendor session, held in parallel to the conference academic sessions, gave an insight into industry latest problems and research interests. To summarize, for me this event was very productive in terms of both: studying and networking.



